

## 8-BIT HIGH-SPEED ANALOG-TO-DIGITAL CONVERTER

#### features

- 8-Bit Resolution
- Differential Linearity Error
  - $\pm$ 0.3 LSB Typ,  $\pm$ 1 LSB Max (25°C)
  - ±1 LSB Max
- Integral Linearity Error
  - $\pm$ 0.6 LSB,  $\pm$ 0.75 LSB Max (25°C)
  - ±1 LSB Max
- Maximum Conversion Rate of 40 Megasamples Per Second (MSPS) Max
- Internal Sample and Hold Function
- 5-V Single Supply Operation
- Low Power Consumption . . . 85 mW Typ
- Analog Input Bandwidth . . . ≥75 MHz Typ
- Internal Reference Voltage Generators

## applications

- Quadrature Amplitude Modulation (QAM) and Quadrature Phase Shift Keying (QPSK) Demodulators
- Digital Television
- Charge-Coupled Device (CCD) Scanners
- Video Conferencing
- Digital Set-Top Box
- Digital Down Converters
- High-Speed Digital Signal Processor Front End

## description

The TLC5540 is a high-speed, 8-bit analog-to-digital converter (ADC) that converts at sampling rates up to 40 megasamples per second (MSPS). Using a semiflash architecture and CMOS process, the TLC5540 is able to convert at high speeds while still maintaining low power consumption and cost. The analog input bandwidth of 75 MHz (typ) makes this device an excellent choice for undersampling applications. Internal resistors are provided to generate 2-V full-scale reference voltages from a 5-V supply, thereby reducing external components. The digital outputs can be placed in a high impedance mode. The TLC5540 requires only a single 5-V supply for operation.

#### (TOP VIEW) OE 24 DGND DGND [] 2 23 REFB 22 REFBS D2 🛮 4 21 AGND D3 🛮 5 20 AGND D4 **1** 6 19 ANALOG IN 18 V<sub>DDA</sub> D5 **1** 7 D6 **∏** 8 17 REFT 16 REFTS D7 **∏** 9 D8(MSB) [] 10 15 VDDA 14 🛮 V<sub>DDA</sub> V<sub>DDD</sub> [] 11 CLK **1** 12 13 V<sub>DDD</sub>

**PW OR NS PACKAGE** 

#### **AVAILABLE OPTIONS**

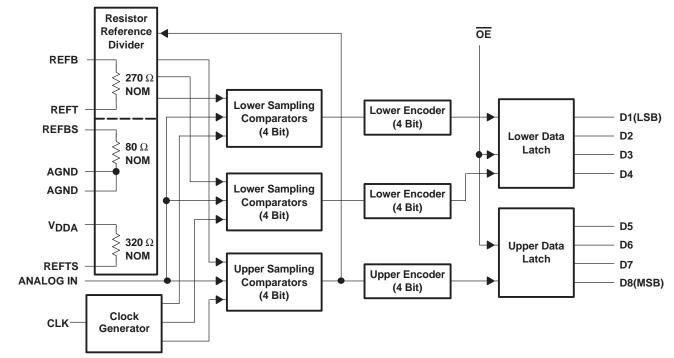
_	PACKAGE						
TA	TSSOP (PW)	SOP (NS)					
−0°C to 70°C	TLC5540CPW	TLC5540CNSLE					
-40°C to 85°C	TLC5540IPW	TLC5540INSLE					



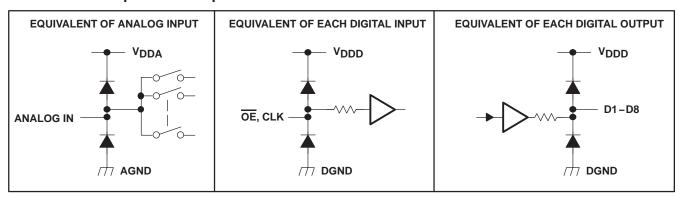
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



## functional block diagram



## schematics of inputs and outputs





## **Terminal Functions**

TERM	INAL		PERCENTION					
NAME	NO.	1/0	DESCRIPTION					
AGND	20, 21		Analog ground					
ANALOG IN	19	I	Analog input					
CLK	12	I	Clock input					
DGND	2, 24		Digital ground					
D1-D8	3-10	0	Digital data out. D1:LSB, D8:MSB					
ŌĒ	1	- 1	Output enable. When $\overline{OE}$ = L, data is enabled. When $\overline{OE}$ = H, D1–D8 is high impedance.					
V <sub>DDA</sub>	14, 15, 18		Analog V <sub>DD</sub>					
$V_{DDD}$	11, 13		Digital V <sub>DD</sub>					
REFB	23	- 1	ADC reference voltage in (bottom)					
REFBS	22		Reference voltage (bottom). When using the internal voltage divider to generate a nominal 2-V reference, the REFBS terminal is shorted to the REFB terminal and the REFTS terminal is shorted to the REFT terminal (see Figure 13 and Figure 14).					
REFT	17	- 1	Reference voltage in (top)					
REFTS	16		Reference voltage (top). When using the internal voltage divider to generate a nominal 2-V reference, the REFTS terminal is shorted to the REFT terminal and the REFBS terminal is shorted to the REFB terminal (see Figure 13 and Figure 14).					

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>DDA</sub> , V <sub>DDD</sub>	7 V
Reference voltage input range, V <sub>I(REFT)</sub> , V <sub>I(REFB)</sub> , V <sub>I(REFBS)</sub> , V <sub>I(REFTS)</sub>	AGND to V <sub>DDA</sub>
Analog input voltage range, V <sub>I(ANLG)</sub>	
Digital input voltage range, V <sub>I(DGTL)</sub>	
Digital output voltage range, VO(DGTL)	
Operating free-air temperature range, T <sub>A</sub> : TLC5540C	0°C to 70°C
TLC5540I	. −40°C to 85°C
Storage temperature range, T <sub>Stq</sub>	-55°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



recommended operating conditions

			MIN	NOM	MAX	UNIT	
	V <sub>DDA</sub> -AGND		4.75	5	5.25	.,	
Supply voltage	V <sub>DDD</sub> -AGND		4.75	5	5.25	V	
	AGND-DGND		-100	0	100	mV	
Reference input voltage (top), VI(REFT	Γ)		V <sub>I(REFB)</sub> +1.8	V <sub>I(REFB)</sub> +2	$V_{DDA}$	V	
Reference input voltage (bottom), VI(R	EFB)		0	0.6	V <sub>I(REFT)</sub> -1.8		
Analog input voltage range, V <sub>I(ANLG)</sub>	(see Note 1)		V <sub>I</sub> (REFB)		V <sub>I</sub> (REFT)		
Full scale voltage, VI(REFT) - VI(REF	B)		1.8		5	V	
High-level input voltage, VIH	,		4			V	
Low-level input voltage, V <sub>IL</sub>					1	V	
Pulse duration, clock high, t <sub>W(H)</sub>			12.5			ns	
Pulse duration, clock low, t <sub>W(L)</sub>			12.5			ns	
	TLC5540C	TLC5540C			70	°C	
Operating free-air temperature, TA	TLC5540I		-40		85	°C	

<sup>(1) 1.8</sup> V ≤ V<sub>I</sub>(REFT) − V<sub>I</sub>(REFB) < V<sub>DD</sub>



## electrical characteristics at $V_{DD}$ = 5 V, $V_{I(REFT)}$ = 2.6 V, $V_{I(REFB)}$ = 0.6 V, $f_{S}$ = 40 MSPS, $T_{A}$ = 25°C (unless otherwise noted)

	PARAMETER	TES	T CONDITIONS	t	MIN	TYP	MAX	UNIT
	Linearity amon internal		T <sub>A</sub> = 25°C			±0.6	±1	
EL	Linearity error, integral	$f_S = 40 \text{ MSPS},$	$T_A = MIN \text{ to } MA$			±1		
-	L'accelle comme d'étance l'al	$V_I = 0.6 \text{ V to } 2.6 \text{ V}$	$V_I = 0.6 \text{ V to } 2.6 \text{ V}$ $T_A = 25^{\circ}\text{C}$ $T_A = \text{MIN to MAX}$			±0.3	±0.75	LSB
ED	Linearity error, differential						±1	
	Self bias (1), V <sub>RB</sub>	Short REFB to REFBS	0 5		0.57	0.61	0.65	
	Self bias (1), V <sub>RT</sub>	Short REFT to REFTS	See Figure 13		2.47	2.63	2.80	.,
	Self bias (2), V <sub>RB</sub>	Short REFB to AGND				AGND		V
	Self bias (2), V <sub>RT</sub>	Short REFT to REFTS	See Figure 14		2.18	2.29	2.4	
I <sub>ref</sub>	Reference-voltage current	VI(REFT) - VI(REFB) =	5.2	7.5	12	mA		
R <sub>ref</sub>	Reference-voltage resistor	Between REFT and REF	165	270	350	Ω		
C <sub>i</sub>	Analog input capacitance	$V_{I(ANLG)} = 1.5 V + 0.07$	V <sub>I(ANLG)</sub> = 1.5 V + 0.07 V <sub>rms</sub>					pF
EZS	Zero-scale error	.,	- > /		-18	-43	-68	.,
EFS	Full-scale error	VI(REFT) - VI(REFB) =	2 V		-25	0	25	mV
lн	High-level input current	V <sub>DD</sub> = 5.25 V,	V <sub>IH</sub> = V <sub>DD</sub>				5	•
IIL	Low-level input current	V <sub>DD</sub> = 5.25 V,	V <sub>IL</sub> = 0				5	μΑ
ЮН	High-level output current	OE = GND,	$V_{DD} = 4.75 V$ ,	$V_{OH} = V_{DD} - 0.5 V$	-1.5			A
loL	Low-level output current	OE = GND,	$V_{DD} = 4.75 V$ ,	V <sub>OL</sub> = 0.4 V	2.5			mA
IOZH(lkg)	High-level high-impedance-state output leakage current	$\overline{OE} = V_{DD}$ ,	V <sub>DD</sub> = 5.25,	V <sub>OH</sub> = V <sub>DD</sub>			16	
IOZL(Ikg)	Low-level high-impedance-state output leakage current	$\overline{OE} = V_{DD}$ ,	V <sub>DD</sub> = 4.75,	V <sub>OL</sub> = 0			16	μА
I <sub>DD</sub>	Supply current	$f_S = 40$ MSPS, $C_L \le 25$ pNTSC‡ ramp wave input				17	27	mA

<sup>†</sup>Conditions marked MIN or MAX are as stated in recommended operating conditions.

‡ National Television System Committee

(1) Supply current specification does not include I<sub>ref</sub>.



# operating characteristics at $V_{DD}$ = 5 V, $V_{RT}$ = 2.6 V, $V_{RB}$ = 0.6 V, $f_s$ = 40 MSPS, $T_A$ = 25°C (unless otherwise noted)

	PARAMETER	TEST C	ONDITIONS†	MIN	TYP	MAX	UNIT	
f <sub>S</sub>	Maximum conversion rate	$T_A = MIN \text{ to } MA$	λX	40			MSPS	
f <sub>S</sub>	Minimum conversion rate	$T_A = MIN \text{ to } MA$	λX		5		MSPS	
BW	Analog input full-power bandwidth	At – 3 dB,	V <sub>I</sub> (ANLG) = 2 V <sub>pp</sub>		75		MHz	
t <sub>pd</sub>	Delay time, digital output	C <sub>L</sub> ≤ 10 pF (see	e Note 2)		9	15	ns	
tPHZ	Disable time, output high to Hi-Z	C <sub>L</sub> ≤ 15 pF,	$I_{OH} = -4.5 \text{ mA}$			20	ns	
tPLZ	Disable time, output low to Hi-Z	C <sub>L</sub> ≤ 15 pF,	I <sub>OL</sub> = 5 mA			20	ns	
<sup>t</sup> PZH	Enable time, Hi-Z to output high	C <sub>L</sub> ≤ 15 pF,	$I_{OH} = -4.5 \text{ mA}$			15	ns	
tPZL	Enable time, Hi-Z to output low	C <sub>L</sub> ≤ 15 pF,	I <sub>OL</sub> = 5 mA			15	ns	
	Differential gain	NTSC 40 IRE‡	modulation wave,		1%			
	Differential phase	f <sub>S</sub> = 14.3 MSPS			0.7		degrees	
t <sub>A</sub> J	Aperture jitter time				30		ps	
t <sub>d(s)</sub>	Sampling delay time				4		ns	
			f <sub>I</sub> = 1 MHz		47		dB	
		,	f <sub>I</sub> = 3 MHz	44	47			
		$f_S = 20 \text{ MSPS}$	f <sub>I</sub> = 6 MHz		46			
SNR	Signal-to-noise ratio		f <sub>I</sub> = 10 MHz		45			
			f <sub>I</sub> = 3 MHz		45.2			
		f <sub>S</sub> = 40 MSPS	f <sub>I</sub> = 6 MHz	42	44		7	
			f <sub>I</sub> = 10 MHz		42			
			f <sub>I</sub> = 1 MHz		7.64			
		( 00 140 00	f <sub>I</sub> = 3 MHz		7.61			
ENOD	Effective acceptance of hits	$f_S = 20 \text{ MSPS}$	f <sub>I</sub> = 6 MHz		7.47		D'i-	
ENOB	Effective number of bits		f <sub>I</sub> = 10 MHz		7.16		Bits	
		4 40 MCDC	f <sub>I</sub> = 3 MHz		7			
		f <sub>S</sub> = 40 MSPS	f <sub>I</sub> = 6 MHz		6.8			
			f <sub>I</sub> = 1 MHz		43			
		£ 20 MCDC	f <sub>I</sub> = 3 MHz	35	42			
TUD	Total harmania diatartian	$f_S = 20 \text{ MSPS}$	f <sub>I</sub> = 6 MHz		41			
THD	Total harmonic distortion		f <sub>I</sub> = 10 MHz		38		dBc	
		f _ 40 Mene	f <sub>I</sub> = 3 MHz		40			
		f <sub>S</sub> = 40 MSPS	f <sub>I</sub> = 6 MHz		38			
	Spurious froe dynamic ronge	f <sub>S</sub> = 20 MSPS	$f_S = 20 \text{ MSPS}$		46		dBo	
	Spurious-free dynamic range	$f_S = 40 \text{ MSPS}$	f <sub>I</sub> = 3 MHz		42		dBc	

<sup>†</sup> Conditions marked MIN or MAX are as stated in recommended operating conditions.

‡ Institute of Radio Engineers

(2) C<sub>L</sub> includes probe and jig capacitance.



## PARAMETER MEASUREMENT INFORMATION

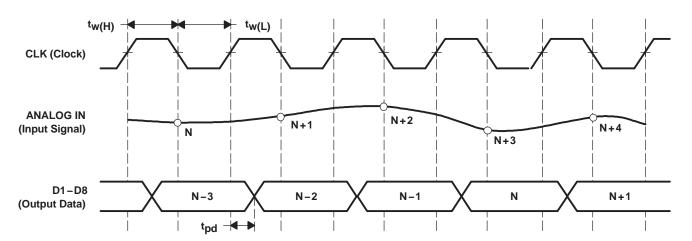


Figure 1. I/O Timing Diagram

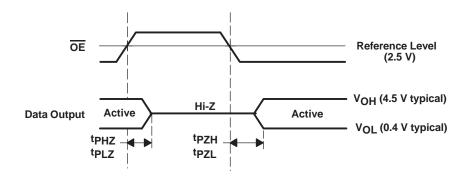


Figure 2. I/O Timing Diagram



#### **TYPICAL CHARACTERISTICS**

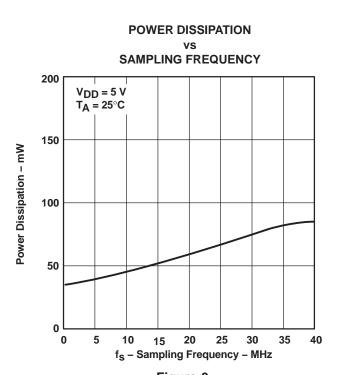
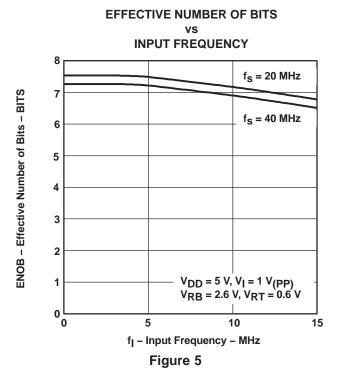


Figure 3



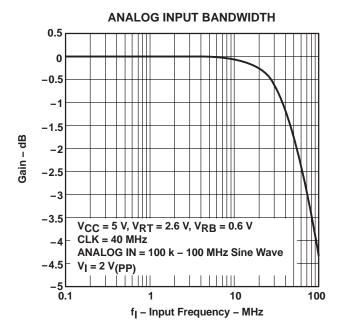
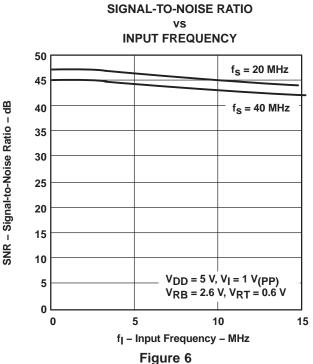


Figure 4





0.8

0.6

0.4 0.2

0 -0.2 -0.4

-0.6 -0.8

0

40

Differential Nonlinearity - LSB

#### TYPICAL CHARACTERISTICS

## **DIFFERENTIAL NONLINEARITY** $V_I = V_{ramp} = 0.6 V - 2.6 V, 500 Hz$ V<sub>RT</sub> = 2.6 V, V<sub>RB</sub> = 0.6 V, V<sub>DD</sub> = 5 V f<sub>S</sub> = 40 MHz T<sub>A</sub> = 25°C

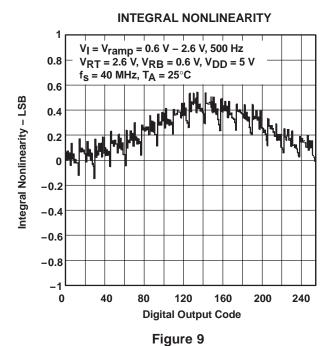
## 120 **Digital Output Code** Figure 7

160

200

240

80



## **EFFECTIVE NUMBER OF BITS**

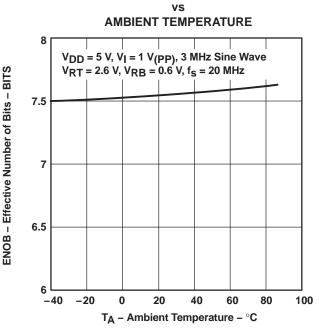


Figure 8

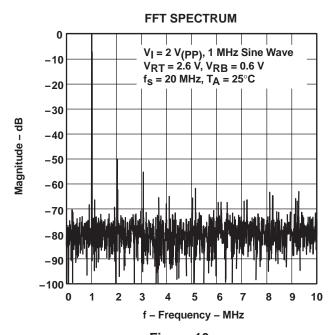


Figure 10



#### APPLICATION INFORMATION

#### grounding and power supply considerations

A signal ground is a low-impedance path for current to return to the source. Inside the TLC5540 A/D converter, the analog ground and digital ground are connected to each other through the substrate, which has a very small resistance ( $\sim$ 30  $\Omega$ ) to prevent internal latch-up. For this reason, it is strongly recommended that a printed circuit board (PCB) of at least 4 layers be used with the TLC5540 and the converter DGND and AGND pins be connected directly to the analog ground plane to avoid a ground loop. Figure 11 shows the recommended decoupling and grounding scheme for laying out a multilayer PC board with the TLC5540. This scheme ensures that the impedance connection between AGND and DGND is minimized so that their potential difference is negligible and noise source caused by digital switching current is eliminated.

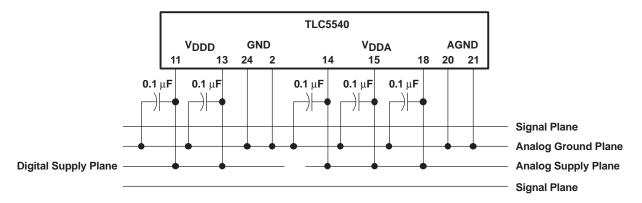


Figure 11. AV<sub>DD</sub>, DV<sub>DD</sub>, AGND, and DGND Connections

## printed circuit board (PCB) layout considerations

When designing a circuit that includes high-speed digital and precision analog signals such as a high speed ADC, PCB layout is a key component to achieving the desired performance. The following recommendations should be considered during the prototyping and PCB design phase:

- Separate analog and digital circuitry physically to help eliminate capacitive coupling and crosstalk. When separate analog and digital ground planes are used, the digital ground and power planes should be several layers from the analog signals and power plane to avoid capacitive coupling.
- Full ground planes should be used. Do not use individual etches to return analog and digital currents or partial ground planes. For prototyping, breadboards should be constructed with copper clad boards to maximize ground plane.
- The conversion clock, CLK, should be terminated properly to reduce overshoot and ringing. Any jitter on the conversion clock degrades ADC performance. A high-speed CMOS buffer such as a 74ACT04 or 74AC04 positioned close to the CLK terminal can improve performance.
- Minimize all etch runs as much as possible by placing components very close together. It also proves beneficial to place the ADC in a corner of the PCB nearest to the I/O connector analog terminals.
- It is recommended to place the digital output data latch (if used) as close to the TLC5540 as possible to minimize capacitive loading. If D0 through D7 must drive large capacitive loads, internal ADC noise may be experienced.



## functional description

The TLC5540 uses a modified semiflash architecture as shown in the functional block diagram. The four most significant bits (MSBs) of every output conversion result are produced by the upper comparator block CB1. The four least significant bits (LSBs) of each alternate output conversion result are produced by the lower comparator blocks CB-A and CB-B in turn (see Figure 12).

The reference voltage that is applied to the lower comparator resistor string is one sixteenth of the amplitude of the refence applied to the upper comparator resistor string. The sampling comparators of the lower comparator block require more time to sample the lower voltages of the reference and residual input voltage. By applying the residual input voltage to alternate lower comparator blocks, each comparator block has twice as much time to sample and convert as would be the case if only one lower comparator block were used.

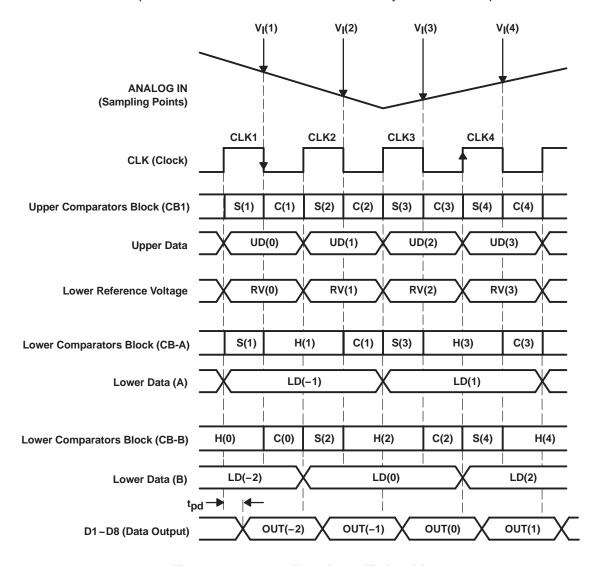


Figure 12. Internal Functional Timing Diagram

This conversion scheme, which reduces the required sampling comparators by 30 percent compared to standard semiflash architectures, achieves significantly higher sample rates than the conventional semiflash conversion method.



## functional description (continued)

The MSB comparator block converts on the falling edge of each applied clock cycle. The LSB comparator blocks CB-A and CB-B convert on the falling edges of the first and second following clock cycles, respectively. The timing diagram of the conversion algorithm is shown in Figure 12.

## analog input operation

The analog input stage to the TLC5540 is a chopper-stabilized comparator and is equivalently shown below:

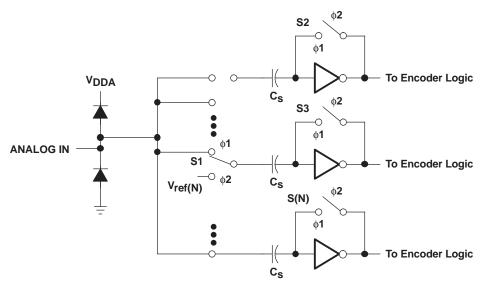


Figure 13. External Connections for Using the Internal Reference Resistor Divider

Figure 13 depicts the analog input for the TLC5540. The switches shown are controlled by two internal clocks,  $\phi 1$  and  $\phi 2$ . These are nonoverlapping clocks that are generated from the CLK input. During the sampling period,  $\phi 1$ , S1 is closed and the input signal is applied to one side of the sampling capacitor,  $C_S$ . Also during the sampling period, S2 through S(N) are closed. This sets the comparator input to approximately 2.5 V. The delta voltage is developed across  $C_S$ . During the comparison phase,  $\phi 2$ , S1 is switched to the appropriate reference voltage for the bit value N. S2 is opened and  $V_{ref(N)} - VC_S$  toggles the comparator output to the appropriate digital 1 or 0. The small resistance values for the switch, S1, and small value of the sampling capacitor combine to produce the wide analog input bandwidth of the TLC5540. The source impedance driving the analog input of the TLC5540 should be less than 100  $\Omega$  across the range of input frequency spectrum.

#### reference inputs - REFB, REFT, REFBS, REFTS

The range of analog inputs that can be converted are determined by REFB and REFT, REFT being the maximum reference voltage and REFB being the minimum reference voltage. The TLC5540 is tested with REFT = 2.6 V and REFB = 0.6 V producing a 2-V full-scale range. The TLC5540 can operate with REFT – REFB = 5 V, but the power dissipation in the reference resistor increases significantly (93 mW nominally). It is recommended that a 0.1  $\mu F$  capacitor be attached to REFB and REFT whether using externally or internally generated voltages.



## internal reference voltage conversion

Three internal resistors allow the device to generate an internal reference voltage. These resistors are brought out on terminals  $V_{DDA}$ , REFTS, REFB, REFBS, and AGND. Two different bias voltages are possible without the use of external resistors.

Internal resistors are provided to develop REFT = 2.6 V and REFB = 0.6 V (bias option one) with only two external connections. This is developed with a 3-resistor network connected to  $V_{DDA}$ . When using this feature, connect REFT to REFTS and connect REFB to REFBS. For applications where the variance associated with  $V_{DDA}$  is acceptable, this internal voltage reference saves space and cost (see Figure 14).

A second internal bias option (bias two option) is shown in Figure 15. Using this scheme REFB = AGND and REFT = 2.28 V nominal. These bias voltage options can be used to provide the values listed in the following table.

DIAG OPTION		BIAS VO	DLTAGE		
BIAS OPTION	$V_{RB}$	V <sub>RT</sub>	V <sub>RT</sub> – V <sub>RB</sub>		
1	0.61	2.63	2.02		
2	AGND	2.28	2.28		

**Table 1. Bias Voltage Options** 

To use the internally-generated reference voltage, terminal connections should be made as shown in Figure 14 or Figure 15. The connections in Figure 14 provide the standard video 2-V reference.

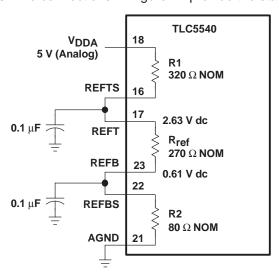


Figure 14. External Connections Using the Internal Bias One Option



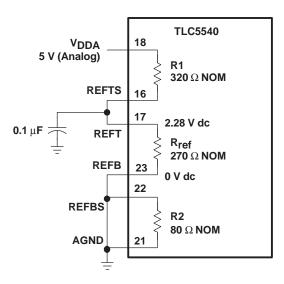


Figure 15. External Connections Using the Internal Bias Two Option

## functional operation

Table 2 shows the TLC5540 functions.

**Table 2. Functional Operation** 

INPUT SIGNAL STEP			DIGITAL OUTPUT CODE							
VOLTAGE	STEP	MSB							LSB	
V <sub>ref(T)</sub>	255	1	1	1	1	1	1	1	1	
•	•	•	•	•	•	•	•	•	•	
•	•	•	•	•	•	•	•	•	•	
•	128	1	0	0	0	0	0	0	0	
•	127	0	1	1	1	1	1	1	1	
•	•	•	•	•	•	•	•	•	•	
•	•	•	•	•	•	•	•	•	•	
V <sub>ref(B)</sub>	0	0	0	0	0	0	0	0	0	





ti.com 6-Dec-2006

#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
TLC5540CNSLE	OBSOLETE	SO	NS	24		TBD	Call TI	Call TI
TLC5540CNSR	ACTIVE	SO	NS	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC5540CNSRG4	ACTIVE	SO	NS	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC5540CPW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TLC5540CPWG4	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TLC5540CPWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TLC5540CPWRG4	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TLC5540INSLE	OBSOLETE	SO	NS	24		TBD	Call TI	Call TI
TLC5540INSR	ACTIVE	SO	NS	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC5540INSRG4	ACTIVE	SO	NS	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC5540IPW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TLC5540IPWG4	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TLC5540IPWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TLC5540IPWRG4	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take



## **PACKAGE OPTION ADDENDUM**

6-Dec-2006

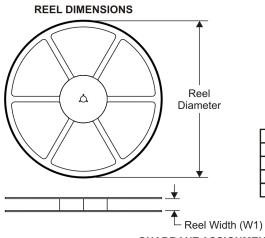
reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

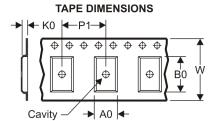
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 14-Aug-2009

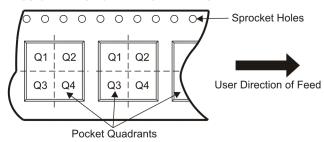
## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

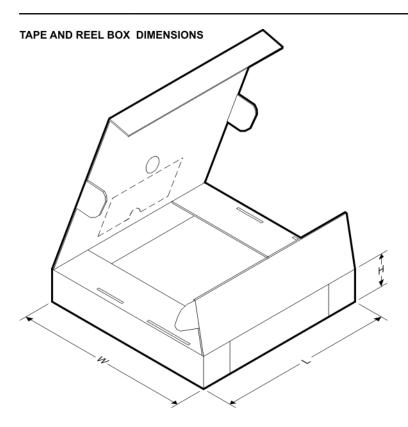
## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

All differsions are normal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC5540CNSR	SO	NS	24	2000	330.0	24.4	8.2	15.4	2.5	12.0	24.0	Q1
TLC5540CPWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1
TLC5540INSR	SO	NS	24	2000	330.0	24.4	8.2	15.4	2.5	12.0	24.0	Q1
TLC5540IPWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

www.ti.com 14-Aug-2009



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLC5540CNSR	SO	NS	24	2000	346.0	346.0	41.0
TLC5540CPWR	TSSOP	PW	24	2000	346.0	346.0	33.0
TLC5540INSR	SO	NS	24	2000	346.0	346.0	41.0
TLC5540IPWR	TSSOP	PW	24	2000	346.0	346.0	33.0

## **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

## 14-PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

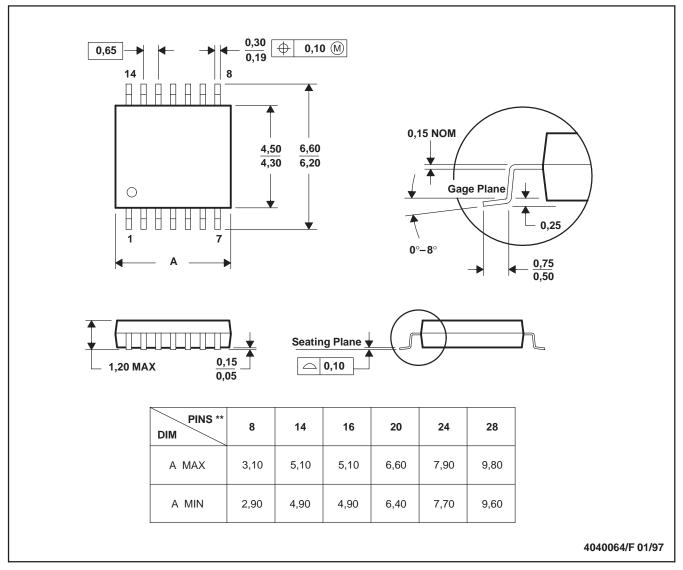
- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## PW (R-PDSO-G\*\*)

#### 14 PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

#### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

**Applications Products Amplifiers** amplifier.ti.com Audio www.ti.com/audio Data Converters Automotive www.ti.com/automotive dataconverter.ti.com **DLP® Products** Broadband www.dlp.com www.ti.com/broadband DSP Digital Control dsp.ti.com www.ti.com/digitalcontrol Clocks and Timers www.ti.com/clocks Medical www.ti.com/medical Military Interface www.ti.com/military interface.ti.com Optical Networking Logic logic.ti.com www.ti.com/opticalnetwork Power Mgmt power.ti.com Security www.ti.com/security Telephony Microcontrollers microcontroller.ti.com www.ti.com/telephony Video & Imaging www.ti-rfid.com www.ti.com/video RF/IF and ZigBee® Solutions www.ti.com/lprf Wireless www.ti.com/wireless

> Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2009, Texas Instruments Incorporated